

Last Revised: 2014-11-06 07:14:37.0

High-Speed M Series Multifunction DAQ for USB - 16-Bit, up to 1.25 MS/s, Integrated BNC Connectivity



- Up to 16 differential BNC analog inputs at 16 bits, 1.25 MS/s (1 MS/s scanning)
- Up to 4 BNC analog outputs at 16 bits, 2.86 MS/s
- Up to 48 TTL/CMOS digital I/O lines (8 BNC, up to 32 hardware-timed at up to 1 MHz)
- Two 32-bit, 80 MHz counter/timers
- Analog and digital triggering supported; power supply included
- NI-PGIA 2 and NI-MCal calibration technology for improved measurement accuracy
- NI signal streaming for 4 high-speed data streams on USB
- NI-DAQmx driver software and LabVIEW SignalExpress LE included

Overview

With recent bandwidth improvements and new innovations from National Instruments, USB has evolved into a core bus of choice for measurement and automation applications. High-speed NI M Series devices for USB deliver high-performance data acquisition in an easy-to-use and portable form factor through USB ports on laptop computers and other portable computing platforms. NI created NI signal streaming, an innovative patent-pending technology that enables sustained bidirectional high-speed data streams on USB. The new technology, combined with advanced external synchronization and isolation, helps engineers and scientists achieve high-performance applications on USB.

NI M Series high-speed multifunction data acquisition (DAQ) modules for USB are optimized for superior accuracy at fast sampling rates. They provide an onboard NI-PGIA 2 amplifier designed for fast settling times at high scanning rates, ensuring 16-bit accuracy even when measuring all available channels at maximum speed. All high-speed devices have a minimum of 16 analog inputs, 24 digital I/O lines, seven programmable input ranges, analog and digital triggering, and two counter/timers. USB M Series devices are ideal for test, control, and design applications including portable data logging, field monitoring, embedded OEM, in-vehicle data acquisition, and academic. High-speed NI USB-625x M Series devices have an extended two-year calibration interval.

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Requirements and Compatibility

OS Information

- Windows 2000/XP
- Windows 7
- Windows Vista x64/x86

Driver Information

- NI-DAQmx

Software Compatibility

- ANSI C/C++
- LabVIEW
- SignalExpress
- Visual C#
- Visual Studio .NET

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Comparison Tables

| Family | Connector | Analog Inputs | Resolution | Max Rate | Analog Outputs | Resolution | Max Rate | Digital I/O | Counter/ Timer |
|--------------|---------------|-----------------|------------|-----------|----------------|------------|-----------|------------------------|----------------|
| USB-6251 BNC | BNC and screw | 8 differential | 16 bits | 1.25 MS/s | 2 | 16 bits | 2.86 MS/s | 24 (8 BNC, 8 clocked) | 2 |
| USB-6259 | BNC and screw | 16 differential | 16 bits | 1.25 MS/s | 4 | 16 bits | 2.86 MS/s | 48 (8 BNC, 32 clocked) | 2 |

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Application and Technology

NI Signal Streaming

Unlike typical multifunction USB data acquisition devices, NI USB M Series DAQ devices incorporate NI signal streaming, a patent-pending technology that combines three innovative hardware- and software-level design elements to enable sustained high-speed and bidirectional data streams over USB. NI signal streaming, along with the error correction, noise rejection, power management, and power distribution inherent in the USB protocol, yields a robust, secure, and reliable bus. Without NI signal streaming, a multifunction data acquisition device could sustain only a single high-speed data stream, effectively making it a single-function device. For more information, visit ni.com/usb.

USB M Series for Test

For test, you can use the M Series high-speed analog inputs and 10 MHz digital lines with direct BNC connectivity for applications including test, component characterization, and sensor measurement. USB M Series multifunction DAQ devices also complement existing test systems that need additional measurement channels. For higher-channel-count signal conditioning on USB, consider the NI CompactDAQ or NI SCXI platform.

USB M Series for Control

USB M Series digital lines can drive 24 mA for relay and actuator control. By clocking the digital lines as fast as 10 MHz (with onboard regeneration), you can use these lines for pulse-width modulation (PWM) to control valves, motors, fans, lamps, and pumps. With four waveform analog outputs, two 80 MHz counter/timers, and four high-speed data streams on USB, M Series devices can execute multiple control loops simultaneously. High-speed USB-625x M Series devices also offer direct support for encoder measurements, protected digital lines, and digital debounce filters. With up to 32 single-ended analog inputs, 32 clocked digital lines, and four analog outputs, you can execute multiple control loops with a single device.

You can also create a complete custom motion controller by combining USB M Series devices with the NI SoftMotion Development Module.

USB M Series for Design

For design applications, you can use a wide range of I/O – from 32 single-ended analog inputs to 48 digital lines – to measure and verify prototype designs. USB M Series devices and NI LabVIEW SignalExpress interactive measurement software deliver benchtop measurements to the PC. With LabVIEW SignalExpress, you can quickly create design verification tests. The fast acquisition and generation rates of high-performance USB M Series high-speed devices along with LabVIEW SignalExpress provide fast design analysis. You can convert your tested and verified LabVIEW SignalExpress projects to LabVIEW applications for immediate M Series DAQ use, and bridge the gap between test, control, and design applications.

USB M Series for OEMs

Shorten your time to market by integrating National Instruments OEM products in your design. Board-only versions of USB M Series DAQ devices are available for OEM applications, with competitive quantity pricing and software customization. The NI OEM Elite Program offers free 30-day trial kits for qualified customers. Visit ni.com/oem for more information.

Recommended Software

National Instruments measurement services software, built around NI-DAQmx driver software, includes intuitive application programming interfaces, configuration tools, I/O assistants, and other tools designed to reduce system setup, configuration, and development time. National Instruments recommends using the latest version of NI-DAQmx driver software for application development in NI LabVIEW, LabVIEW SignalExpress, LabWindows™/CVI, and Measurement Studio. To obtain the latest version of NI-DAQmx, visit ni.com/support/daq/versions. NI measurement services software speeds up your development with features including:

- A guide to create fast and accurate measurements with no programming using the DAQ Assistant
- Automatic code generation to create your application in LabVIEW; LabWindows/CVI; LabVIEW SignalExpress; and Visual Studio .NET, ANSI C/C++, C#, or Visual Basic using Measurement Studio
- Multithreaded streaming technology for 1,000 times performance improvements
- Automatic timing, triggering, and synchronization routing to make advanced applications easy
- More than 3,000 free software downloads to jump-start your project available at ni.com/zone
- Software configuration of all digital I/O features without hardware switches/jumpers
- Single programming interface for analog input, analog output, digital I/O, and counters on hundreds of multifunction DAQ hardware devices

M Series devices are compatible with the following versions (or later) of NI application software – LabVIEW, LabWindows/CVI, or Measurement Studio versions 7.x or LabVIEW SignalExpress 2.x.

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Ordering Information

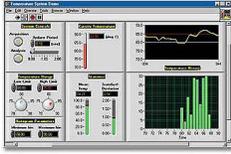
For a complete list of accessories, visit the product page on ni.com.

| Products | Part Number | Recommended Accessories | Part Number |
|---------------------------------------------------------------------------------------|-------------|--------------------------|-------------|
| High-Speed M Series Multifunction DAQ for USB with Integrated BNC Connectivity | | | |
| USB-6251 BNC | 780115-0P | No accessories required. | |
| USB-6259 BNC | 780114-0P | No accessories required. | |
| Board-Only Devices for Embedded Systems and OEM | | | |
| USB-6251 OEM (Quantity 1) | 194929-03 | No accessories required. | |
| USB-6259 OEM (Quantity 1) | 194929-01 | No accessories required. | |

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Software Recommendations

LabVIEW Professional Development System for Windows



- Advanced software tools for large project development
- Automatic code generation using DAQ Assistant and Instrument I/O Assistant
- Tight integration with a wide range of hardware
- Advanced measurement analysis and digital signal processing
- Open connectivity with DLLs, ActiveX, and .NET objects
- Capability to build DLLs, executables, and MSI installers

SignalExpress for Windows



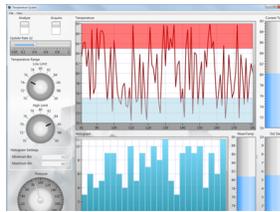
- Quickly configure projects without programming
- Control over 400 PC-based and stand-alone instruments
- Log data from more than 250 data acquisition devices
- Perform basic signal processing, analysis, and file I/O
- Scale your application with automatic LabVIEW code generation
- Create custom reports or easily export data to LabVIEW, DIAdem or Microsoft Excel

NI LabWindows™/CVI for Windows



- Real-time advanced 2D graphs and charts
- Complete hardware compatibility with IVI, VISA, DAQ, GPIB, and serial
- Analysis tools for array manipulation, signal processing statistics, and curve fitting
- Simplified cross-platform communication with network variables
- Measurement Studio .NET tools (included in LabWindows/CVI Full only)
- The mark LabWindows is used under a license from Microsoft Corporation.

NI Measurement Studio Professional Edition



- Customizable graphs and charts for WPF, Windows Forms, and ASP.NET Web Forms UI design
- Analysis libraries for array operations, signal generation, windowing, filters, signal processing
- Hardware integration support with native .NET data acquisition and instrument control libraries
- Automatic code generation for all NI-DAQmx data acquisition hardware
- Intelligent and efficient data-logging libraries for streaming measurement data to disk
- Support for Microsoft Visual Studio .NET 2012/2010/2008

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Support and Services

Calibration

NI measurement hardware is calibrated to ensure measurement accuracy and verify that the device meets its published specifications. To ensure the ongoing accuracy of your measurement hardware, NI offers basic or detailed recalibration service that provides ongoing ISO 9001 audit compliance and confidence in your measurements. To learn more about NI calibration services or to locate a qualified service center near you, contact your local sales office or visit ni.com/calibration.

Technical Support

Get answers to your technical questions using the following National Instruments resources.

- **Support** - Visit ni.com/support to access the NI KnowledgeBase, example programs, and tutorials or to contact our applications engineers who are located in NI sales offices around the world and speak the local language.
- **Discussion Forums** - Visit forums.ni.com for a diverse set of discussion boards on topics you care about.
- **Online Community** - Visit community.ni.com to find, contribute, or collaborate on customer-contributed technical content with users like you.

Repair

While you may never need your hardware repaired, NI understands that unexpected events may lead to necessary repairs. NI offers repair services performed by highly trained technicians who quickly return your device with the guarantee that it will perform to factory specifications. For more information, visit ni.com/repair.

Training and Certifications

The NI training and certification program delivers the fastest, most certain route to increased proficiency and productivity using NI software and hardware. Training builds the skills to more efficiently develop robust, maintainable applications, while certification validates your knowledge and ability.

- **Classroom training in cities worldwide** - the most comprehensive hands-on training taught by engineers.
- **On-site training at your facility** - an excellent option to train multiple employees at the same time.
- **Online instructor-led training** - lower-cost, remote training if classroom or on-site courses are not possible.
- **Course kits** - lowest-cost, self-paced training that you can use as reference guides.
- **Training memberships** and training credits - to buy now and schedule training later.

Visit ni.com/training for more information.

Extended Warranty

NI offers options for extending the standard product warranty to meet the life-cycle requirements of your project. In addition, because NI understands that your requirements may change, the extended warranty is flexible in length and easily renewed. For more information, visit ni.com/warranty.

OEM

NI offers design-in consulting and product integration assistance if you need NI products for OEM applications. For information about special pricing and services for OEM customers, visit ni.com/oem.

Alliance

Our Professional Services Team is comprised of NI applications engineers, NI Consulting Services, and a worldwide National Instruments Alliance Partner program of more than 700 independent consultants and integrators. Services range from start-up assistance to turnkey system integration. Visit ni.com/alliance.

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Detailed Specifications

Specifications listed below are typical at 25 °C unless otherwise noted. Refer to the *M Series User Manual* for more information about NI 625x devices.

| Analog Input | |
|------------------------------------------------------------------|------------------------------------------------------------------|
| Number of channels | |
| NI 6250/6251 | 8 differential or 16 single ended |
| NI 6254/6259 | 16 differential or 32 single ended |
| NI 6255 | 40 differential or 80 single ended |
| ADC resolution | 16 bits |
| DNL | No missing codes guaranteed |
| INL | Refer to the <i>AI Absolute Accuracy Table</i> |
| Sampling rate | |
| Maximum | |
| NI 6250/6251/6254/6259 | 1.25 MS/s single channel, 1.00 MS/s multi-channel (aggregate) |
| NI 6255 | 1.25 MS/s single channel 750 kS/s multi-channel (aggregate) |
| Minimum | |
| Timing accuracy | 50 ppm of sample rate |
| Timing resolution | 50 ns |
| Input coupling | DC |
| Input range | ±10 V, ±5 V, ±2 V, ±1 V, ±0.5 V, ±0.2 V, ±0.1 V |
| Maximum working voltage for analog inputs (signal + common mode) | ±11 V of AI GND |
| CMRR (DC to 60 Hz) | 100 dB |
| Input impedance | |
| Device on | |
| AI+ to AI GND | >10 GΩ in parallel with 100 pF |
| AI- to AI GND | >10 GΩ in parallel with 100 pF |
| Device off | |
| AI+ to AI GND | 820 Ω |
| AI- to AI GND | 820 Ω |
| Input bias current | ±100 pA |
| Crosstalk (at 100 kHz) | |
| Adjacent channels | -75 dB |
| Non-adjacent channels | -90 dB ¹ |
| Small signal bandwidth (-3 dB) | 1.7 MHz |
| Input FIFO size | 4,095 samples |
| Scan list memory | 4,095 entries |
| Data transfers | |
| PCI/PCIe/PXI/PXIE devices | DMA (scatter-gather), interrupts, programmed I/O |
| USB devices | USB Signal Stream, programmed I/O |

Overvoltage protection (AI <0..79>, AI SENSE, AI SENSE 2)

| | |
|--------------------------------------------|------------------------------|
| Device on | ±25 V for up to four AI pins |
| Device off | ±15 V for up to four AI pins |
| Input current during overvoltage condition | ±20 mA max/AI pin |

¹ For USB-6255 devices, channel AI <0..15> crosstalk to channel AI <64..79> is -67 dB; applies to channels with 64-channel separation, for example, AI (x) and AI (x + 64).

Settling Time for Multichannel Measurements

NI 6250/6251/6254/6259

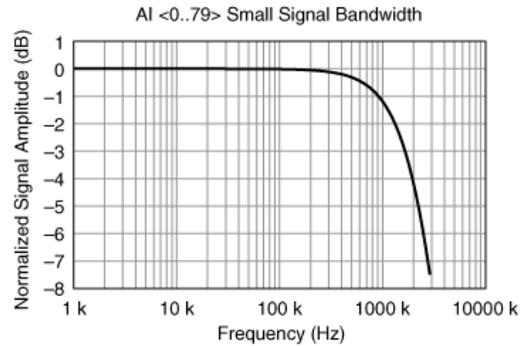
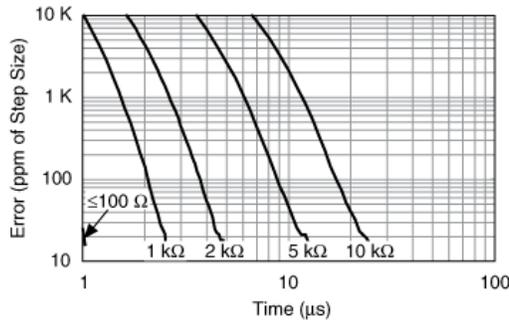
| Range | ±60 ppm of Step (±4 LSB for Full Scale Step) | ±15 ppm of Step (±1 LSB for Full Scale Step) |
|-------------------------|----------------------------------------------|----------------------------------------------|
| ±10 V, ±5 V, ±2 V, ±1 V | 1 μs | 1.5 μs |
| ±0.5 V | 1.5 μs | 2 μs |
| ±0.2 V, ±0.1 V | 2 μs | 8 μs |

NI 6255

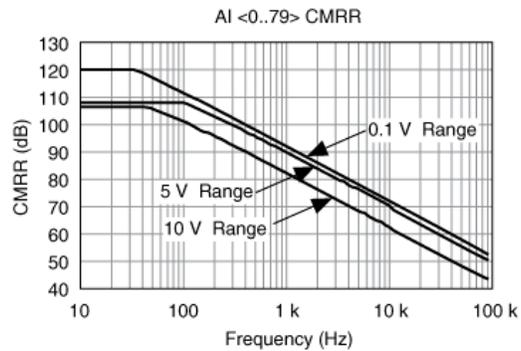
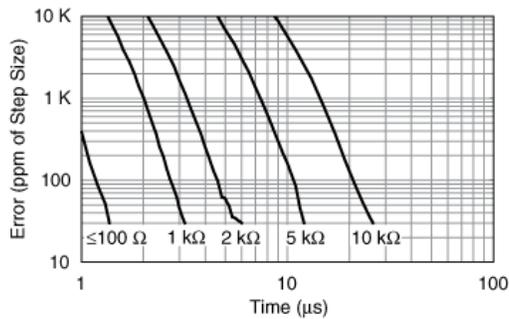
| Range | ±60 ppm of Step (±4 LSB for Full Scale Step) | ±15 ppm of Step (±1 LSB for Full Scale Step) |
|-------------------------|----------------------------------------------|----------------------------------------------|
| ±10 V, ±5 V, ±2 V, ±1 V | 1.3 μs | 1.6 μs |
| ±0.5 V | 1.8 μs | 2.5 μs |
| ±0.2 V, ±0.1 V | 3 μs | 8 μs |

Typical Performance Graphs

NI 6250/6251/6254/6259
Settling Error Versus Time for Different Source Impedances



NI 6255
Settling Error Versus Time for Different Source Impedances



| Analog Triggers | |
|-----------------------------|-----------------------------------------------------------------------------------------------------|
| Number of triggers | 1 |
| Source | |
| NI 6250/6251 | AI <0..15>, APFI 0 |
| NI 6254/6259 | AI <0..31>, APFI <0..1> |
| NI 6255 | AI <0..79>, APFI 0 |
| Functions | Start Trigger, Reference Trigger, Pause Trigger, Sample Clock, Convert Clock, Sample Clock Timebase |
| Source level | |
| AI <0..79> | ±full scale |
| APFI <0..1> | ±10 V |
| Resolution | 10 bits, 1 in 1,024 |
| Modes | Analog edge triggering, analog edge triggering with hysteresis, and analog window triggering |
| Bandwidth (-3 dB) | |
| AI <0..79> | 3.4 MHz |
| APFI <0..1> | 3.9 MHz |
| Accuracy | ±1% |
| APFI <0..1> characteristics | |
| Input impedance | 10 kΩ |
| Coupling | DC |
| Protection | |
| Power on | ±30 V |
| Power off | ±15 V |

| Analog Output | |
|----------------------|-------------------------------------------------|
| Number of channels | |
| NI 6250/6254 | 0 |
| NI 6251/6255 | 2 |
| NI 6259 | 4 |
| DAC resolution | 16 bits |
| DNL | ±1 LSB |
| Monotonicity | 16 bit guaranteed |
| Accuracy | Refer to the <i>AO Absolute Accuracy Table</i> |
| Maximum update rate | |
| 1 channel | 2.86 MS/s |
| 2 channels | 2.00 MS/s |
| 3 channels | 1.54 MS/s |
| 4 channels | 1.25 MS/s |
| Timing accuracy | 50 ppm of sample rate |
| Timing resolution | 50 ns |
| Output range | ±10 V, ±5 V, ±external reference on APFI <0..1> |
| Output coupling | DC |
| Output impedance | 0.2 Ω |
| Output current drive | ±5 mA |
| Overdrive protection | ±25 V |
| Overdrive current | 20 mA |

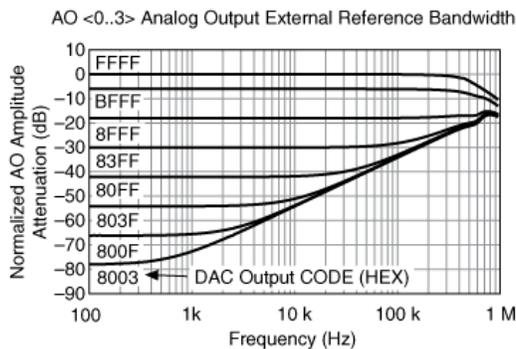
| | |
|----------------------------------------------------------------------------|--------------------------------------------------|
| Power-on state | $\pm 5 \text{ mV}^2$ |
| Power-on glitch | 1.5 V peak for 1.5 s |
| Output FIFO size | 8,191 samples shared among channels used |
| Data transfers | |
| PCI/PCIe/PXI/PXLe devices | DMA (scatter-gather), interrupts, programmed I/O |
| USB devices | USB Signal Stream, programmed I/O |
| AO waveform modes: | |
| ▪ Non-periodic waveform | |
| ▪ Periodic waveform regeneration mode from onboard FIFO | |
| ▪ Periodic waveform regeneration from host buffer including dynamic update | |
| Settling time, full scale step 15 ppm (1 LSB) | 2 μs |
| Slew rate | 20 V/ μs |
| Glitch energy at midscale transition, $\pm 10 \text{ V}$ range | |
| Magnitude | 10 mV |
| Duration | 1 μs |

² For all USB-6251/6259 Screw Terminal devices, when powered on, the analog output signal is not defined until after USB configuration is complete.

External Reference

APFI <0..1> characteristics

| | |
|-----------------|---------------------|
| Input impedance | 10 k Ω |
| Coupling | DC |
| Protection | |
| Power on | $\pm 30 \text{ V}$ |
| Power off | $\pm 15 \text{ V}$ |
| Range | $\pm 11 \text{ V}$ |
| Slew rate | 20 V/ μs |



Calibration (AI and AO)

| | |
|--------------------------|------------|
| Recommended warm-up time | 15 minutes |
| Calibration interval | 2 years |

AI Absolute Accuracy Table

| Nominal Range | | Residual Gain Error (ppm of Reading) | Gain Tempco (ppm/ $^{\circ}\text{C}$) | Reference Tempco | Residual Offset Error (ppm of Range) | Offset Tempco (ppm of Range/ $^{\circ}\text{C}$) | INL Error (ppm of Range) | Random Noise, σ (μVrms) | Absolute Accuracy at Full Scale ¹ (μV) | Sensitivity ² (μV) |
|---------------------|---------------------|--------------------------------------|----------------------------------------|------------------|--------------------------------------|---------------------------------------------------|--------------------------|---------------------------------------------|----------------------------------------------------------------|--------------------------------------------|
| Positive Full Scale | Negative Full Scale | | | | | | | | | |
| 10 | -10 | 60 | 13 | 1 | 20 | 21 | 60 | 280 | 1,920 | 112.0 |
| 5 | -5 | 70 | 13 | 1 | 20 | 21 | 60 | 140 | 1,010 | 56.0 |
| 2 | -2 | 70 | 13 | 1 | 20 | 24 | 60 | 57 | 410 | 22.8 |
| 1 | -1 | 80 | 13 | 1 | 20 | 27 | 60 | 32 | 220 | 12.8 |
| 0.5 | -0.5 | 90 | 13 | 1 | 40 | 34 | 60 | 21 | 130 | 8.4 |

| | | | | | | | | | | |
|-----|-------|-----|----|---|-----|----|----|----|----|-----|
| 0.2 | - 0.2 | 130 | 13 | 1 | 80 | 55 | 60 | 16 | 74 | 6.4 |
| 0.1 | - 0.1 | 150 | 13 | 1 | 150 | 90 | 60 | 15 | 52 | 6.0 |

Accuracies listed are valid for up to two years from the device external calibration.

$$\text{AbsoluteAccuracy} = \text{Reading} \cdot (\text{GainError}) + \text{Range} \cdot (\text{OffsetError}) + \text{NoiseUncertainty}$$

$$\text{GainError} = \text{ResidualGainError} + \text{GainTempco} \cdot (\text{TempChangeFromLastInternalCal}) + \text{ReferenceTempco} \cdot (\text{TempChangeFromLastExternalCal})$$

$$\text{OffsetError} = \text{ResidualOffsetError} + \text{OffsetTempco} \cdot (\text{TempChangeFromLastInternalCal}) + \text{INL_Error}$$

$$\text{NoiseUncertainty} = \frac{\text{RandomNoise} \cdot 3}{\sqrt{100}} \quad \text{For a coverage factor of } 3 \sigma \text{ and averaging 100 points.}$$

¹ Absolute accuracy at full scale on the analog input channels is determined using the following assumptions:

$$\text{TempChangeFromLastExternalCal} = 10 \text{ }^\circ\text{C}$$

$$\text{TempChangeFromLastInternalCal} = 1 \text{ }^\circ\text{C}$$

$$\text{number_of_readings} = 100$$

$$\text{CoverageFactor} = 3 \sigma$$

For example, on the 10 V range, the absolute accuracy at full scale is as follows:

$$\text{GainError} = 60 \text{ ppm} + 13 \text{ ppm} \cdot 1 + 1 \text{ ppm} \cdot 10 \quad \text{GainError} = 83 \text{ ppm}$$

$$\text{OffsetError} = 20 \text{ ppm} + 21 \text{ ppm} \cdot 1 + 60 \text{ ppm} \quad \text{OffsetError} = 101 \text{ ppm}$$

$$\text{NoiseUncertainty} = \frac{275 \text{ } \mu\text{V} \cdot 3}{\sqrt{100}} \quad \text{NoiseUncertainty} = 83 \text{ } \mu\text{V}$$

$$\text{AbsoluteAccuracy} = 10 \text{ V} \cdot (\text{GainError}) + 10 \text{ V} \cdot (\text{OffsetError}) + \text{NoiseUncertainty} \quad \text{AbsoluteAccuracy} = 1920 \text{ } \mu\text{V}$$

² Sensitivity is the smallest voltage change that can be detected. It is a function of noise.

AO Absolute Accuracy Table

| Nominal Range | | Residual Gain Error (ppm of Reading) | Gain Tempco (ppm/°C) | Reference Tempco | Residual Offset Error (ppm of Range) | Offset Tempco (ppm of Range/°C) | INL Error (ppm of Range) | Absolute Accuracy at Full Scale ¹ (μV) |
|---------------------|---------------------|--------------------------------------|----------------------|------------------|--------------------------------------|---------------------------------|--------------------------|---------------------------------------------------|
| Positive Full Scale | Negative Full Scale | | | | | | | |
| 10 | -10 | 75 | 17 | 1 | 40 | 2 | 64 | 2,080 |
| 5 | -5 | 85 | 8 | 1 | 40 | 2 | 64 | 1,045 |

¹ Absolute Accuracy at full scale numbers is valid immediately following internal calibration and assumes the device is operating within 10 °C of the last external calibration.

Accuracies listed are valid for up to two years from the device external calibration.

$$\text{AbsoluteAccuracy} = \text{OutputValue} \cdot (\text{GainError}) + \text{Range} \cdot (\text{OffsetError})$$

$$\text{GainError} = \text{ResidualGainError} + \text{GainTempco} \cdot (\text{TempChangeFromLastInternalCal}) + \text{ReferenceTempco} \cdot (\text{TempChangeFromLastExternalCal})$$

$$\text{OffsetError} = \text{ResidualOffsetError} + \text{AOOffsetTempco} \cdot (\text{TempChangeFromLastInternalCal}) + \text{INL_Error}$$

Digital I/O/PFI

Static Characteristics

Number of channels

NI 6250/6251/6255 24 total, 8 (P0.<0..7>), 16 (PFI <0..7>/P1, PFI <8..15>/P2)

NI 6254/6259 48 total, 32 (P0.<0..31>), 16 (PFI <0..7>/P1, PFI <8..15>/P2)

Ground reference D GND

Direction control Each terminal individually programmable as input or output

Pull-down resistor 50 kΩ typ, 20 kΩ min

Input voltage protection³ ±20 V on up to two pins

³ Stresses beyond those listed under Input voltage protection may cause permanent damage to the device.

Waveform Characteristics (Port 0 Only)

Terminals used

NI 6250/6251/6255 Port 0 (P0.<0..7>)

NI 6254/6259 Port 0 (P0.<0..31>)

| | |
|-------------------------------------------|------------------------------------------------------------------------------------------------------------------|
| Port/sample size | |
| NI 6250/6251/6255 | Up to 8 bits |
| NI 6254/6259 | Up to 32 bits |
| Waveform generation (DO) FIFO | 2,047 samples |
| Waveform acquisition (DI) FIFO | 2,047 samples |
| DI Sample Clock frequency | |
| PCI/PCIe/PXI/PXle devices | 0 to 10 MHz ⁴ |
| USB devices | 0 to 1 MHz system dependent ⁴ |
| DO Sample Clock frequency | |
| PCI/PCIe/PXI/PXle devices | |
| Regenerate from FIFO | 0 to 10 MHz |
| Streaming from memory | 0 to 1 MHz system dependent ⁴ |
| USB devices | |
| Regenerate from FIFO | 0 to 10 MHz |
| Streaming from memory | 0 to 1 MHz system dependent ⁴ |
| Data transfers | |
| PCI/PCIe/PXI/PXle devices | DMA (scatter-gather), interrupts, programmed I/O |
| USB devices | USB Signal Stream, programmed I/O |
| DO or DI Sample Clock source ⁵ | Any PFI, RTSI, AI Sample or Convert Clock, AO Sample Clock, Ctr <i>n</i> Internal Output, and many other signals |

⁴ Performance can be dependent on bus latency and volume of bus activity.

⁵ The digital subsystem does not have its own dedicated internal timing engine. Therefore, a sample clock must be provided from another subsystem on the device or an external source.

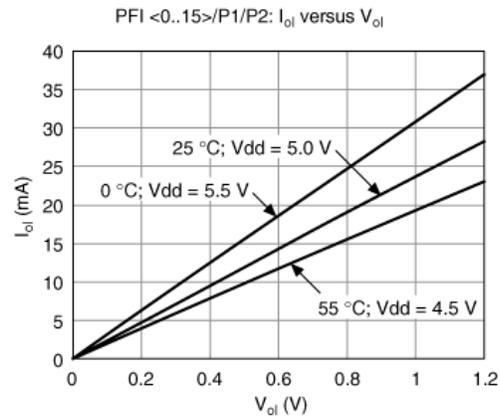
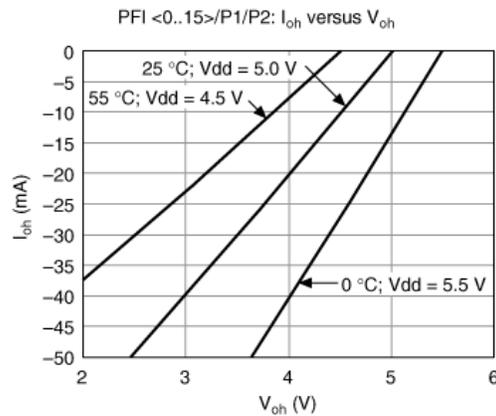
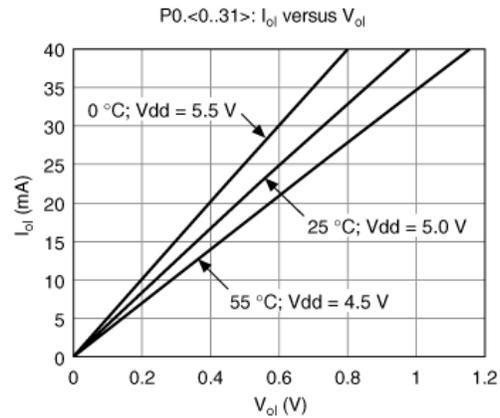
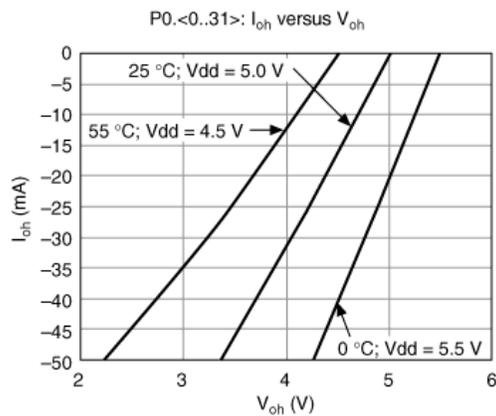
PFI/Port 1/Port 2 Functionality

| | |
|--------------------------|------------------------------------------------------------------------------------|
| Functionality | Static digital input, static digital output, timing input, timing output |
| Timing output sources | Many AI, AO, counter, DI, DO timing signals |
| Debounce filter settings | 125 ns, 6.425 µs, 2.56 ms, disable; high and low transitions; selectable per input |

| Recommended Operation Conditions ⁶ | | |
|-----------------------------------------------|-------|--------|
| Level | Min | Max |
| Input high voltage (V_{IH}) | 2.2 V | 5.25 V |
| Input low voltage (V_{IL}) | 0 V | 0.8 V |
| Output high current (I_{OH}) | | |
| P0.<0..31> | — | -24 mA |
| PFI <0..15>/P1/P2 | — | -16 mA |
| Output low current (I_{OL}) | | |
| P0.<0..31> | — | 24 mA |
| PFI <0..15>/P1/P2 | — | 16 mA |

| Electrical Characteristics | | |
|-----------------------------------------------|-------|--------|
| Level | Min | Max |
| Positive-going threshold (V_{T+}) | — | 2.2 V |
| Negative-going threshold (V_{T-}) | 0.8 V | — |
| Delta VT hysteresis ($V_{T+} - V_{T-}$) | 0.2 V | — |
| I_{IL} input low current ($V_{in} = 0$ V) | — | -10 µA |
| I_{IH} input high current ($V_{in} = 5$ V) | — | 250 µA |

Digital I/O Characteristics⁶



⁶ On earlier versions of the USB-6251 Screw Terminal (part numbers 194929A/B/C-0x) and the USB-6259 Screw Terminal (part numbers 194021B/C-0x), the digital I/O characteristics of P0.<16..31> match the characteristics of PFI <0..15>. Refer to the November 2006 version of the *NI 625x Specifications* (part number 371291G-01) for more details.

General-Purpose Counter/Timers

| | |
|-------------------------------|--------------------------------------------------------------------------------------------|
| Number of counter/timers | 2 |
| Resolution | 32 bits |
| Counter measurements | Edge counting, pulse, semi-period, period, two-edge separation |
| Position measurements | X1, X2, X4 quadrature encoding with Channel Z reloading; two-pulse encoding |
| Output applications | Pulse, pulse train with dynamic updates, frequency division, equivalent time sampling |
| Internal base clocks | 80 MHz, 20 MHz, 0.1 MHz |
| External base clock frequency | 0 MHz to 20 MHz |
| Base clock accuracy | 50 ppm |
| Inputs | Gate, Source, HW_Arm, Aux, A, B, Z, Up_Down |
| Routing options for inputs | Any PFI, RTSI, PXI_TRIG, PXI_STAR, analog trigger, many internal signals |
| FIFO | 2 samples |
| Data transfers | |
| PCI/PCIe/PXI/PXle devices | Dedicated scatter-gather DMA controller for each counter/timer; interrupts, programmed I/O |
| USB devices | USB Signal Stream, programmed I/O |

Frequency Generator

| | |
|---------------------|-----------------|
| Number of channels | 1 |
| Base clocks | 10 MHz, 100 kHz |
| Divisors | 1 to 16 |
| Base clock accuracy | 50 ppm |

Output can be available on any PFI or RTSI terminal.

Phase-Locked Loop (PLL)

| | |
|------------------|----------------------------------------------------------------------------------------------------|
| Number of PLLs | 1 |
| Reference signal | PXI_STAR, PXI_CLK10, RTSI <0..7> |
| Output of PLL | 80 MHz Timebase; other signals derived from 80 MHz Timebase including 20 MHz and 100 kHz Timebases |

External Digital Triggers

| | |
|--------------------------------------------|-----------------------------------------------------------------------------------------------------|
| Source | Any PFI, RTSI, PXI_TRIG, PXI_STAR |
| Polarity | Software-selectable for most signals |
| Analog input function | Start Trigger, Reference Trigger, Pause Trigger, Sample Clock, Convert Clock, Sample Clock Timebase |
| Analog output function | Start Trigger, Pause Trigger, Sample Clock, Sample Clock Timebase |
| Counter/timer functions | Gate, Source, HW_Arm, Aux, A, B, Z, Up_Down |
| Digital waveform generation (DO) function | Sample Clock |
| Digital waveform acquisition (DI) function | Sample Clock |

Device-To-Device Trigger Bus

| | |
|--------------------------|-----------------------------------------------------------------------------------------|
| PCI/PCIe devices | RTSI <0..7> ⁷ |
| PXI/PXIe devices | PXI_TRIG <0..7>, PXI_STAR |
| USB devices | None |
| Output selections | 10 MHz Clock; frequency generator output; many internal signals |
| Debounce filter settings | 125 ns, 6.425 μ s, 2.56 ms, disable; high and low transitions; selectable per input |

⁷ In other sections of this document, *RTSI* refers to RTSI <0..7> for PCI/PCIe devices or PXI_TRIG <0..7> for PXI/PXIe devices.

Bus Interface

| | |
|------------------------------------------|-----------------------------------------------------------------------------------------------------------------|
| PCI/PXI devices | 3.3 V or 5 V signal environment |
| PCIe devices | |
| Form factor | x1 PCI Express, specification v1.0a compliant |
| Slot compatibility | x1, x4, x8, and x16 PCI Express slots ⁸ |
| PXIe devices | |
| Form factor | x1 PXI Express peripheral module, specification rev 1.0 compliant |
| Slot compatibility | x1 and x4 PXI Express or PXI Express hybrid slots |
| USB devices | USB 2.0 Hi-Speed or full-speed ^{9,10} |
| DMA channels (PCI/PCIe/PXI/PXIe devices) | 6, analog input, analog output, digital input, digital output, counter/timer 0, counter/timer 1 |
| USB Signal Stream (USB devices) | 4, can be used for analog input, analog output, digital input, digital output, counter/timer 0, counter/timer 1 |

All PXI-625x devices support one of the following features:

- May be installed in PXI Express hybrid slots
- Or, may be used to control SCXI in PXI/SCXI combo chassis

| M Series Device | M Series Part Number | SCXI Control in PXI/SCXI Combo Chassis | PXI Express Hybrid Slot Compatible |
|-----------------------------------------|------------------------|----------------------------------------|------------------------------------|
| PXI-6250 | 191325D-04/191325E-04L | No | Yes |
| PXI-6251 | 191325D-03/191325E-03L | No | Yes |
| | 191325D-13/191325E-13L | Yes | No |
| PXI-6254 | 191325D-02/191325E-03L | No | Yes |
| PXI-6255 | 193618A-01 | No | Yes |
| PXI-6259 | 191325D-01/191325E-01L | No | Yes |
| | 191325D-11/191325E-11L | Yes | No |
| Earlier versions of PXI-6251/ 6254/6259 | 191325C-0x 191325B-0x | Yes | No |

All NI PXIe-625x devices may be installed in PXI Express slots or PXI Express hybrid slots.

⁸ Some motherboards reserve the x16 slot for graphics use. For PCI Express guidelines, refer to ni.com/pciexpress.

⁹ If you are using a USB M Series device in full-speed mode, device performance will be lower and you will not be able to achieve maximum sampling/update rates.

¹⁰ Operating on a full-speed bus may result in lower high-speed full-speed performance.

Power Requirements

Current draw from bus during no-load condition¹¹

| | |
|-----------------|---------|
| PCI/PXI devices | |
| +5 V | 0.03 A |
| +3.3 V | 0.725 A |
| +12 V | 0.35 A |
| PCIe devices | |
| +3.3 V | 0.925 A |
| +12 V | 0.35 A |
| PXIe devices | |
| +3.3 V | 0.45 A |
| +12 V | 0.5 A |

Current draw from bus during AI and AO overvoltage condition¹¹

| | |
|-----------------|--------|
| PCI/PXI devices | |
| +5 V | 0.03 A |
| +3.3 V | 1.2 A |
| +12 V | 0.38 A |
| PCIe devices | |
| +3.3 V | 1.4 A |
| +12 V | 0.38 A |
| PXIe devices | |
| +3.3 V | 0.48 A |
| +12 V | 0.71 A |

 **Caution** USB-625x devices must be powered with NI offered AC adapter or a National Electric Code (NEC) Class 2 DC source that meets the power requirements for the device and has appropriate safety certification marks for country of use.

USB power supply requirements

11 to 30 VDC, 20 W, locking or non-locking power jack with 0.080" diameter center pin, 5/16-32 thread for locking collars

¹¹ Does not include P0/PFI/P1/P2 and +5 V terminals.

Power Limits

 **Caution** Exceeding the power limits may cause unpredictable behavior by the device and/or PC/chassis.

PCI devices

| | |
|-----------------------------|-----------------------|
| +5 V terminal (connector 0) | 1 A max ¹² |
| +5 V terminal (connector 1) | 1 A max ¹² |

PCIe devices

| | |
|----------------------------------------------|--------------------------|
| Without disk drive power connector installed | |
| +5 V terminals combined | 0.35 A max ¹² |
| P0/PFI/P1/P2 and +5 V terminals combined | 0.39 A max |
| With disk drive power connector installed | |
| +5 V terminal (connector 0) | 1 A max ¹² |
| +5 V terminal (connector 1) | 1 A max ¹² |
| P0/PFI/P1/P2 combined | 0.39 A max |

PXI/PXIe devices

| | |
|-----------------------------|-----------------------|
| +5 V terminal (connector 0) | 1 A max ¹² |
|-----------------------------|-----------------------|

| | |
|------------------------------------------|-----------------------|
| +5 V terminal (connector 1) | 1 A max ¹² |
| P0/PFI/P1/P2 and +5 V terminals combined | 2 A max |
| USB devices | |
| +5 V terminal | 1 A max ¹² |
| P0/PFI/P1/P2 and +5 V terminals combined | 2 A max |
| Power supply fuse | 2 A, 250 V |

¹² Has a self-resetting fuse that opens when current exceeds this specification.

Physical Requirements

Printed circuit board dimensions

| | |
|--------------------------------------|---------------------------------------------|
| NI PCI-6250/6251/6254/6255/6259 | 9.7 × 15.5 cm (3.8 × 6.1 in.) |
| NI PCIe-6251/6259 | 9.9 × 16.8 cm (3.9 × 6.6 in.) (half-length) |
| NI PXI/PXIe-6250/6251/6254/6255/6259 | Standard 3U PXI |

Enclosure dimensions (includes connectors)

| | |
|----------------------------------------|-----------------------------------------------------|
| NI USB-6251/6255/6259 Screw Terminal | 26.67 × 17.09 × 4.45 cm (10.5 × 6.73 × 1.75 in.) |
| NI USB-6251/6259 BNC | 28.6 × 17 × 6.9 cm (11.25 × 6.7 × 2.7 in.) |
| NI USB-6251/6255/6259 Mass Termination | 18.8 × 17.09 × 4.45 cm (7.4 × 6.73 × 1.75 in.) |
| NI USB-6251/6255/6259 OEM | Refer to the <i>NI USB-622x/625x OEM User Guide</i> |

Weight

| | |
|----------------------------------------|----------------------|
| NI PCI-6250 | 142 g (5 oz) |
| NI PCI-6251 | 149 g (5.2 oz) |
| NI PCI-6254 | 152 g (5.3 oz) |
| NI PCI-6255 | 164 g (5.8 oz) |
| NI PCI-6259 | 162 g (5.6 oz) |
| NI PCIe-6251 | 161 g (5.7 oz) |
| NI PCIe-6259 | 175 g (6.1 oz) |
| NI PXI-6250 | 212 g (7.5 oz) |
| NI PXI-6251/6254 | 222 g (7.8 oz) |
| NI PXI-6255 | 236 g (8.3 oz) |
| NI PXI-6259 | 233 g (8.2 oz) |
| NI PXIe-6251 | 208 g (7.3 oz) |
| NI PXIe-6259 | 221 g (7.8 oz) |
| NI USB-6251 Screw Terminal | 1.2 kg (2 lb 10 oz) |
| NI USB-6255/6259 Screw Terminal | 1.24 kg (2 lb 11 oz) |
| NI USB-6251/6255/6259 Mass Termination | 816 g (1 lb 12.8 oz) |
| NI USB-6251 OEM | 140 g (4.9 oz) |
| NI USB-6255/6259 OEM | 172 g (6.1 oz) |

I/O connector

| | |
|-------------------------------------|--------------------------------|
| NI PCI/PCIe/PXI/PXIe-6250/6251 | 1 68-pin VHDCI |
| NI PCI/PCIe/PXI/PXIe-6254/6255/6259 | 2 68-pin VHDCI |
| NI USB-6251 Screw Terminal | 64 screw terminals |
| NI USB-6255/6259 Screw Terminal | 128 screw terminals |
| NI USB-6251 BNC | 21 BNCs and 30 screw terminals |
| NI USB-6259 BNC | 32 BNCs and 60 screw terminals |
| NI USB-6251 Mass Termination | 1 68-pin SCSI |
| NI USB-6255/6259 Mass Termination | 2 68-pin SCSI |

| | |
|---------------------------------------------------------------------------|----------------------------------------------------|
| Disk drive power connector (PCIe devices) | Standard ATX peripheral connector (not serial ATA) |
| USB-6251/6255/6259 Screw Terminal/USB-6251/6259 BNC screw terminal wiring | 16-28 AWG |

Maximum Working Voltage¹³

| | |
|----------------------------------------------|------------------------------|
| NI 6250/6251/6254/6255/6259 channel-to-earth | 11 V, Measurement Category I |
|----------------------------------------------|------------------------------|

 **Caution** Do *not* use for measurements within Categories II, III, or IV.

¹³ Maximum working voltage refers to the signal voltage plus the common-mode voltage.

Environmental

| | |
|------------------------------------|-----------------------------|
| Operating temperature | |
| PCI/PXI/PXle devices | 0 to 55 °C |
| PCIe devices | 0 to 50 °C |
| USB devices | 0 to 45 °C |
| Storage temperature | -20 to 70 °C |
| Humidity | 10 to 90% RH, noncondensing |
| Maximum altitude | 2,000 m |
| Pollution Degree (indoor use only) | 2 |

Shock and Vibration (PXI/PXle Devices Only)

| | |
|-------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Operational shock | 30 g peak, half-sine, 11 ms pulse (Tested in accordance with IEC-60068-2-27. Test profile developed in accordance with MIL-PRF-28800F.) |
| Random vibration | |
| Operating | 5 to 500 Hz, 0.3 g _{rms} |
| Nonoperating | 5 to 500 Hz, 2.4 g _{rms} (Tested in accordance with IEC-60068-2-64. Nonoperating test profile exceeds the requirements of MIL-PRF-28800F, Class 3.) |

Safety

This product is designed to meet the requirements of the following standards of safety for electrical equipment for measurement, control, and laboratory use:

- IEC 61010-1, EN 61010-1
- UL 61010-1, CSA 61010-1

 **Note** For UL and other safety certifications, refer to the product label or visit ni.com/certification, search by model number or product line, and click the appropriate link in the Certification column.

Electromagnetic Compatibility

This product is designed to meet the requirements of the following standards of EMC for electrical equipment for measurement, control, and laboratory use:

- EN 61326 EMC requirements; Minimum Immunity
- EN 55011 Emissions; Group 1, Class A
- CE, C-Tick, ICES, and FCC Part 15 Emissions; Class A

 **Note** For EMC compliance, operate this device with shielded cables.

CE Compliance

This product meets the essential requirements of applicable European Directives, as amended for CE marking, as follows:

- 73/23/EEC; Low-Voltage Directive (safety)
- 89/336/EEC; Electromagnetic Compatibility Directive (EMC)

 **Note** Refer to the Declaration of Conformity (DoC) for this product for any additional regulatory compliance information. To obtain the DoC for this product, visit ni.com/certification, search by model number or product line, and click the appropriate link in the Certification column.

Environmental Management

National Instruments is committed to designing and manufacturing products in an environmentally responsible manner. NI recognizes that eliminating certain hazardous substances from our products is beneficial not only to the environment but also to NI customers.

For additional environmental information, refer to the NI and the Environment Web page at ni.com/environment. This page contains the environmental regulations and directives with which NI complies, as well as other environmental information not included in this document.

Waste Electrical and Electronic Equipment (WEEE)

At the end of their life cycle, all products must be sent to a WEEE recycling center. For more information about WEEE recycling centers and National Instruments WEEE initiatives, visit ni.com/environment/weee.htm.

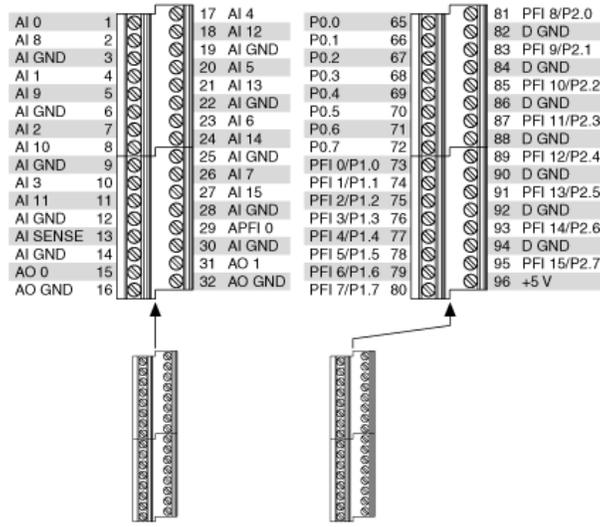
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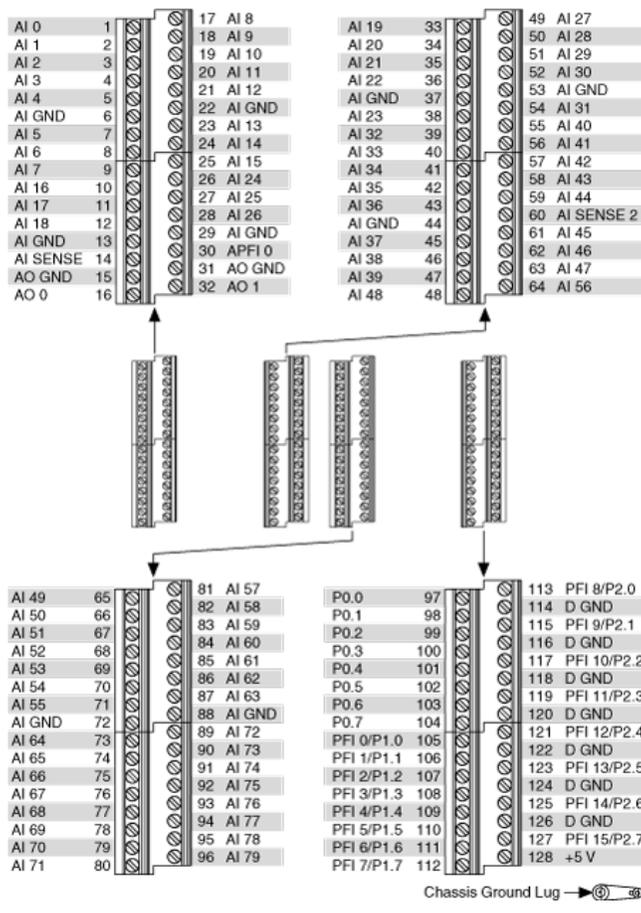
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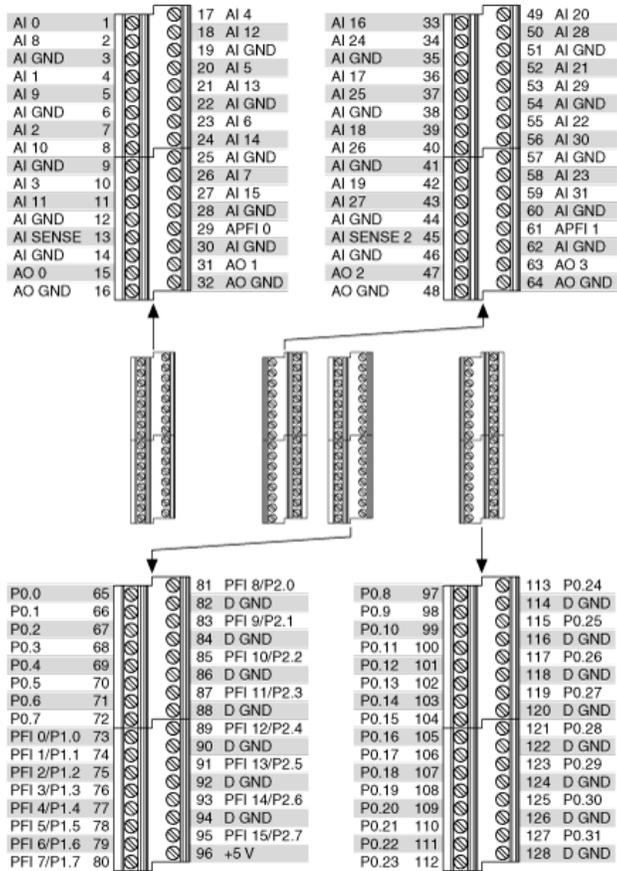
Pinouts/Front Panel Connections



NI USB-6251 Screw Terminal Pinout



NI USB-6255 Screw Terminal Pinout



NI USB-6259 Screw Terminal Pinout

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